

IN THE U.S. PATENT AND TRADEMARK OFFICE

10/500876

In re application of

Albert-Claude BOCCARA et al.

Conf.

Application No. **NEW NATIONAL PHASE**

Group

Filed July 7, 2004

Examiner

METHOD AND DEVICE FOR LOCAL PROBE MICROSCOPIC VISUALIZATION OF A
THREE-DIMENSIONAL OBJECT**INFORMATION DISCLOSURE STATEMENT**
(SUBMISSION CONCURRENT WITH THE
FILING OF A NEW PATENT APPLICATION)Assistant Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

July 7, 2004

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- ☐ Copies of the U.S. patents or publications are not submitted since the USPTO has waived their submission for applications filed after June 30, 2003.
- ☒ Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- ☒ This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

III. CONCISE EXPLANATION OF THE RELEVANCE
(check at least one box)

DI18 Res'd PCT/PTO 07 JUL 2004
10/500876

a. ☒ **DOCUMENTS IN THE ENGLISH LANGUAGE**

The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy.

b. ☐ **DOCUMENTS NOT IN THE ENGLISH LANGUAGE**

A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:

c. ☒ **FOREIGN SEARCH REPORT OR ACTION**

An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).

d. ☐ **OTHER**

The following additional information is provided for the Examiner's consideration.

FEEs

This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.

If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.

Respectfully submitted,

YOUNG & THOMPSON

Benoit Castel

Benoit Castel, Reg. No. 35,041
745 South 23rd Street
Arlington, VA 22202
Telephone (703) 521-2297
Telefax (703) 685-0573
703) 979-4709

BC/lmt

Enclosures: ☒ Form PTO-1449(s)
☒ Documents
☒ Foreign Search Report
☐ Other: _____

(Use several sheets if necessary)

0510-1101

NEW NATIONAL PHASE

Albert-Claude BOCCARA et al.

July 7, 2004

Group Art Unit:

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	2 777 664	10/22/1999	FRANCE				
	196 32 637	2/19/1998	GERMANY				
	2 757 278	6/19/1998	FRANCE				
	96/24875	8/15/1996	INTERNATIONAL			*	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

G. Li et al., "Interference Microscopy for Three-Dimensional Imaging with Wavelength-To-Depth Encoding", Optics Letters, Optical Society of America, Washington, US, Vol. 25, No. 20, October 15, 2000, pages 1505-1507. XP000981018

EXAMINER:

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

* English language abstract provided for the Examiner's convenience

BC/Int

Y&T July 6, 2004